SMD Power Inductor

HPC6045NF-Series

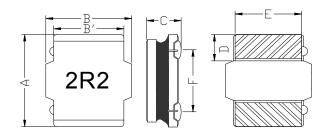
		ECN HIS	STORY LIS	т	
REV	DATE	DESCRIPTION	APPROVED	CHECKED	DRAWN
1.0	16/08/11	新發行	楊祥忠	詹偉特	何秦芝
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SMD Power Inductor

1. Features

- 1. This specification applies Low Profile Power Inductors.
- 2. 100% Lead(Pb) & Halogen-Free and RoHS compliant.

2. Dimension



B'(mm)

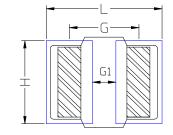
4.8±0.2

C(mm)

4.2±0.3

Halogen	P
Halogen-free	Pb-fre

Recommended Land pattern



L(mm)	G(mm)	G1(mm)	H(mm)
6.5	4.25	1.80min	4.8

3. Part Numbering

HPC6045NF 6.0±0.3 6.0±0.3

A(mm)

B(mm)

Series

		,							
HPC	<mark>6045</mark>	NF	-	2R2	Y				
А	В	С		D	Е				
A: Series B: Dimer C: Type			A/B	*C					
D: Induct	ance ance Tolerar	nce	M=± mar	2=2.20uh 10 220%,Y=±3 king directio pnetic shield	0%. n cannot c	,		unidirect	ional.

D(mm)

1.7±0.3

E(mm)

F(mm)

4.5±0.3 4.25±0.3

HPC6045NF-Series

4. Specification

Part Number HPC6045NF-R36	Inductance L0 (uH) @ 0 A		Tole	rance						
HPC6045NF-R36	@UA		L0 (uH)			Temperature current I rms (A)		Saturation current I sat (A)		DCR (mΩ) @25℃ ±20%.
HPC6045NF-R36		κ	L	м	Y	Тур	Мах	Тур	Max	±20%.
	0.36	1	1	±20%	±30%	9.00	8.50	18.00	16.50	4.80
HPC6045NF-R47	0.47	1	1	±20%	±30%	8.60	8.00	17.00	16.00	6.80
HPC6045NF-R82	0.82	1	1	±20%	±30%	8.20	7.50	14.50	13.50	8.50
HPC6045NF-1R0	1.00	1	1	±20%	±30%	8.00	7.30	13.50	12.50	10.0
HPC6045NF-1R2	1.20	1	1	±20%	±30%	7.50	7.00	12.50	11.50	10.5
HPC6045NF-1R3	1.30	1	1	±20%	±30%	7.50	7.00	12.50	11.50	10.5
HPC6045NF-1R5	1.50	1	1	±20%	±30%	7.00	6.60	12.00	11.00	11.7
HPC6045NF-1R8	1.80	1	1	±20%	±30%	6.80	6.20	11.00	10.00	12.0
HPC6045NF-2R0	2.00	1	1	±20%	±30%	6.50	5.80	10.50	9.50	13.5
HPC6045NF-2R2	2.20	/	1	±20%	±30%	6.00	5.30	9.50	8.55	15.0
HPC6045NF-2R3	2.30	1	1	±20%	±30%	5.80	5.00	9.30	8.20	16.0
HPC6045NF-3R0	3.00	1	1	±20%	±30%	5.20	4.60	8.00	7.50	20.0
HPC6045NF-3R3	3.30	/	1	±20%	±30%	5.00	4.50	7.80	7.30	21.0
HPC6045NF-3R6	3.60	/	1	±20%	±30%	4.90	4.30	7.40	6.90	22.5
HPC6045NF-4R7	4.70	1	±15%	±20%	±30%	4.50	4.00	6.80	6.20	26.0
HPC6045NF-5R6	5.60	1	±15%	±20%	±30%	4.10	3.70	6.40	5.70	31.0
HPC6045NF-6R3	6.30	/	±15%	±20%	±30%	3.80	3.50	5.90	5.30	33.0
HPC6045NF-6R8	6.80	1	±15%	±20%	±30%	3.60	3.30	5.70	5.15	34.0
HPC6045NF-8R2	8.20	1	±15%	±20%	±30%	3.40	2.90	5.10	4.50	46.0
HPC6045NF-100	10.0	±10%	±15%	±20%	±30%	3.20	2.60	4.60	4.20	52.0
HPC6045NF-150	15.0	±10%	±15%	±20%	±30%	2.80	2.20	3.80	3.30	71.0
HPC6045NF-180	18.0	±10%	±15%	±20%	±30%	2.60	2.10	3.40	2.90	80.0
HPC6045NF-220	22.0	±10%	±15%	±20%	±30%	2.30	1.90	3.30	2.70	96.0
HPC6045NF-330	33.0	±10%	±15%	±20%	±30%	1.80	1.50	2.50	2.10	145
HPC6045NF-470	47.0	±10%	±15%	±20%	±30%	1.60	1.20	2.00	1.75	200
HPC6045NF-560	56.0	±10%	±15%	±20%	±30%	1.40	1.00	1.80	1.65	230
HPC6045NF-680	68.0	±10%	±15%	±20%	±30%	1.10	0.92	1.60	1.52	305
HPC6045NF-820	82.0	±10%	±15%	±20%	±30%	0.98	0.88	1.50	1.40	365
HPC6045NF-101	100	±10%	±15%	±20%	±30%	0.92	0.82	1.33	1.25	456
HPC6045NF-121	120	±10%	±15%	±20%	±30%	0.85	0.79	1.20	1.10	500
HPC6045NF-151	150	±10%	±15%	±20%	±30%	0.75	0.70	1.10	1.00	626
HPC6045NF-181	180	±10%	±15%	±20%	±30%	0.68	0.60	1.00	0.90	745
HPC6045NF-221	220	±10%	±15%	±20%	±30%	0.60	0.50	0.88	0.77	900
HPC6045NF-331	330	±10%	±15%	±20%	±30%	0.55	0.45	0.60	0.55	1400
HPC6045NF-471	470	±10%	±15%	±20%	±30%	0.40	0.35	0.50	0.45	2050

Note:

1. All test data referenced to $25^\circ\!\mathrm{C}$ $\,$ ambient , Ls/Q:1MHz/1V.

2. Testing Instrument : HP4284A,CH11025,CH3302,CH1320 ,CH1320S LCR METER / Rdc:CH502BC MICRO OHMMETER.

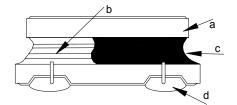
3. Heat Rated Current (Irms) will cause the coil temperature rise approximately Δt of 40 °C (keep 1min.).

4. Saturation Current (Isat) will cause L0 $\,$ to drop $\,$ 30% typical. (keep quickly).

5. The part temperature (ambient + temp rise) should not exceed 125°C under worst case operating conditions. Circuit design, component, PCB trace size and thickness, airflow and other cooling provisions all affect the part temperature. Part temperature should be verified in the end application.

6. Special inquiries besides the above common used types can be met on your requirement.

5. Material List

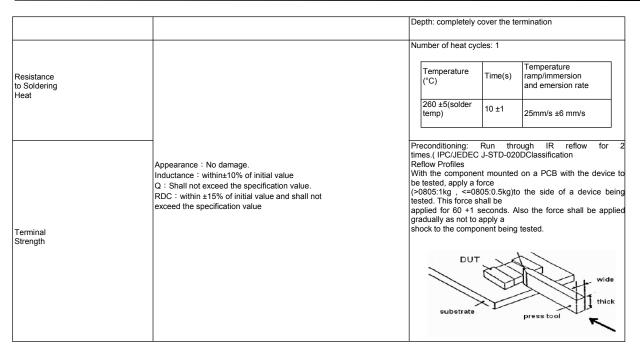


NO	Items	Materials
а	Core	Ferrite Core
b	Wire	Copper Wire
с	Coating	Epoxy with magnetic
d	Solder	Lead free

6. Reliability and Test Condition

Item	Performance	Test Condition				
Operating temperature	-40~+125°C (Including self - temperature rise)					
Storage temperature	-40~+125℃ (on board)					
Electrical Performance Test						
Inductance		HP4284A,CH11025,CH3302,CH1320,CH1320S LCR Meter.				
DCR	 Refer to standard electrical characteristics list. 	CH502BC, Agilent33420A Micro-Ohm Meter.				
Saturation Current (Isat)	△L30% typical.	Saturation DC Current (Isat) will cause L0 to drop \triangle L(%)(keep quickly).				
Heat Rated Current (Irms)	Approximately ∆T≦40℃	Heat Rated Current (Irms) will cause the coil temperature rise △T(°C) without core loss. 1. Applied the allowed DC current(keep 1 min.). 2. Temperature measured by digital surface thermometer				
Reliability Test		· · · · · · · · · · · · · · · · · · ·				
Life Test		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles) Temperature : 125±2°C (Bead) Temperature : 85±2°C (Inductor) Applied current : rated current Duration : 1000±12hrs Measured at room temperature after placing for 24±2 hrs				
Load Humidity		Preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Humidity : 85±2% R.H, Temperature : 85℃±2℃ Duration : 1000hrs Min. with 100% rated current Measured at room temperature after placing for 24±2 hrs				
Thermal shock	Appearance : No damage. Inductance : within±10% of initial value	$eq:preconditioning: Run through IR reflow for 2 times.(IPC/JEDEC J-STD-020DClassification Reflow Profiles Condition for 1 cycle Step 1: -40+2°C 30±5min Step 2: 25+2°C \leq 0.5min Step 3: 105±2°C 30±5min Number of cycles : 500 Measured at room temperature after placing for 24±2 hrs$				
Vibration	Q : Shall not exceed the specification value. RDC : within ±15% of initial value and shall not exceed the specification value	Oscillation Frequency: 10~2K~10Hz for 20 minutes Equipment : Vibration checker Total Amplitude:1.52mm±10% Testing Time : 12 hours(20 minutes, 12 cycles each of 3 orientations) -				
Shock		Peak Normal Wave Velocity				
Bending		Type value duration (D) Wave form change (g's) (ms) (V)ft/sec Shall be mounted on a FR4 substrate of the fdlloWhth dimEnsions: >=0805.40x100k/#2fnine 15.4 chost-rdx100x0.8mm = 15.4 betardge depth98=0805:1.2mm Half-sine 12.3				
		 duration of 10 sec.				

Item	Performance	Test Method and Remarks
	More than 95% of the terminal electrode should be covered with solder $^{\circ}$	Preheat: 150℃,60sec. ∘ Solder: Sn99.5%-Cu0. 5% ∘ Temperature: 245±5℃ ∘ Flux for lead free: Rosin. 9.5% ∘ Dip time: 4±1sec ∘



7. Soldering and Mounting

(1) Soldering

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. TAI-TECH terminations are suitable for re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.

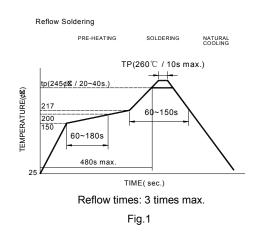
(2) Solder re-flow:

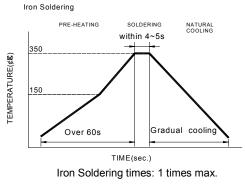
Recommended temperature profiles for re-flow soldering in Figure 1.

(3) Soldering Iron:

Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150 $^\circ\!\!\mathbb{C}$ · Never contact the ceramic with the iron tip
- · Use a 20 watt soldering iron with tip diameter of 1.0mm • 355℃ tip temperature (max) · 1.0mm tip diameter (max) Limit soldering time to 4~5sec.

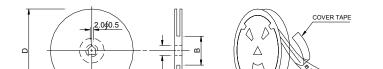






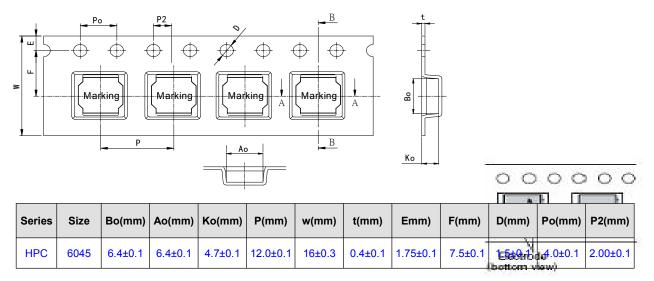
8. Packaging Information

(1) Reel Dimension



Туре	A(mm)	B(mm)	C(mm)	D(mm)
13"x16mm	16.5±0.5	80±2.0	13.5±0.5	330±3.0

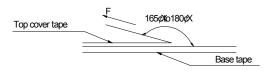
(2) Tape Dimension



(3) Packaging Quantity

НРС	6045
Reel	1000
Inner box	2000
Carton	8000

(4) Tearing Off Force



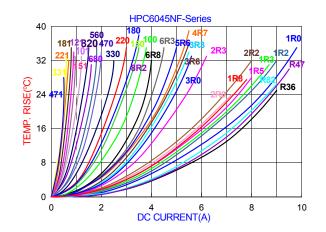
The force for tearing off cover tape is 10 to 130 grams in the arrow direction under the following conditions(referenced ANSI/EIA-481-C-2003 of 4.11 stadnard).

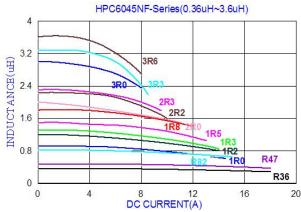
Room Temp.	Room Humidity	Room atm	Tearing Speed
(℃)	(%)	(hPa)	mm/min
5~35	45~85	860~1060	300

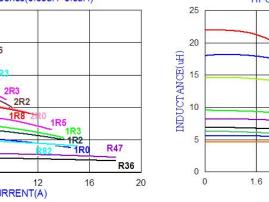
Application Notice

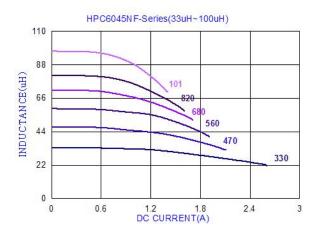
- Storage Conditions (component level)
- To maintain the solderability of terminal electrodes:
- 1. TAI-TECH products meet IPC/JEDEC J-STD-020D standard-MSL, level 1.
- 2. Temperature and humidity conditions: Less than 40 $^\circ\!\!\mathbb{C}$ $\,$ and 60% RH.
- 3. Recommended products should be used within 12 months form the time of delivery.
- 4. The packaging material should be kept where no chlorine or sulfur exists in the air.
- Transportation
- 1. Products should be handled with care to avoid damage or contamination from perspiration and skin oils.
- The use of tweezers or vacuum pick up is strongly recommended for individual components.
 Bulk handling should ensure that abrasion and mechanical shock are minimized.

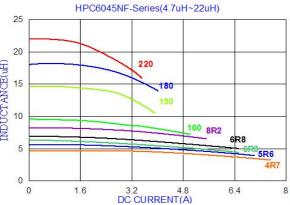
9. Typical Performance Curves

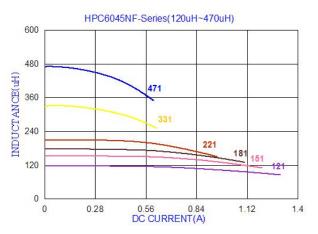






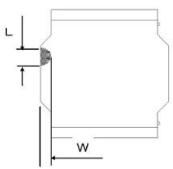






Core chipping

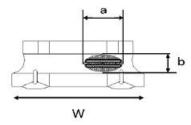
The appearance standard of the chipping size on top side, and bottom side ferrite core is listed below.



L	w
1.5mm Max.	1.5mm Max.

Void appearance tolerance Limit

Size of voids occurring to coating resin is specified below.



Exposed wire tolerance limit of coating resin part on product side. Size of exposed wire occurring to coating resin is specified below. 1. Width direction (dimension a): Acceptable when $a \leq w/2$.

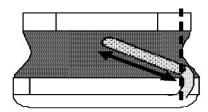
2. Length direction (dimension b): Dimension b is not specified.

The total area of exposed wire occurring to each sides is

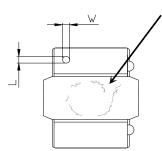
not greater than 50% of coating resin area, and is acceptable.

External appearance criterion for exposed wire

Exposed end of the winding wire at the secondary side should be 3mm and below.



Electrode appearance criterion for exposed wire



Visual check on core surface with no crack means pass.

Conforming

Only top side of wire is exposed. (regardless of whole tope side of wire exposed)

Less than 1/2 of joint side length. (More than 1/2 is selected as defect)

Wire is soldered insufficiently and less than half of outer diameter is covered with solder.



Electrodes with foreign body (dirt) appearance standards Foreign materials (dirt) will not affect the coplanarity of PAD, below the example of foreign materials (dirt) quantity ≤2PCS on single PAD. dimension range as below.